Se	arch l	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/616,987	SCHLOSS ET AL.	
Examiner	Art Unit	
TUYEN T. NGUYEN	2832	

	SEAR	CHED	
Class	Subclass	Date	Examiner
336	90-96, 107, 192	2/5/2005	TTN
123	634-635	2/5/2005	TTN
update	d-	7/19/05	TTN
			-
	:		

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCH	i es I strategy	()
	DATE	EXMR
<u> </u>		
		•
•		
		}
		-
		İ
		ļ